

# Synthesis and Physical Properties of Phase-Engineered Transition Metal Dichalcogenide Monolayer Heterostructures

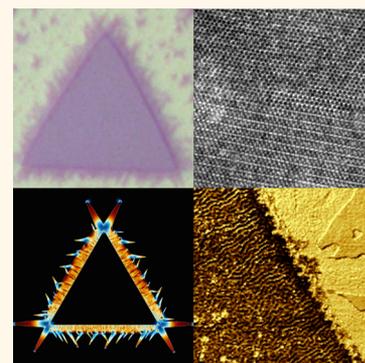
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## S Supporting Information

**ABSTRACT:** Heterostructures of transition metal dichalcogenides (TMDs) offer the attractive prospect of combining distinct physical properties derived from different TMD structures. Here, we report direct chemical vapor deposition of in-plane monolayer heterostructures based on 1H-MoS<sub>2</sub> and 1T'-MoTe<sub>2</sub>. The large lattice mismatch between these materials led to intriguing phenomena at their interface. Atomic force microscopy indicated buckling in the 1H region. Tip-enhanced Raman spectroscopy showed mode structure consistent with Te substitution in the 1H region during 1T'-MoTe<sub>2</sub> growth. This was confirmed by atomic resolution transmission electron microscopy, which also revealed an atomically stitched, dislocation-free 1H/1T' interface. Theoretical modeling revealed that both the buckling and absence of interfacial misfit dislocations were explained by lateral gradients in Te substitution levels within the 1H region and elastic coupling between 1H and 1T' domains. Phase field simulations predicted 1T' morphologies with spike-shaped islands at specific orientations consistent with experiments. Electrical measurements across the heterostructure confirmed its electrical continuity. This work demonstrates the feasibility of dislocation-free stitching of two different atomic configurations and a pathway toward direct synthesis of monolayer TMD heterostructures of different phases.

**KEYWORDS:** heterostructure, phase engineering, chemical vapor deposition, monolayer, two-dimensional materials



The study of two-dimensional materials “beyond graphene” has grown rapidly.<sup>1,2</sup> Transition metal dichalcogenides (TMDs) are a broad materials family whose diverse composition and atomic structures enable numerous different physical and chemical properties.<sup>3–6</sup> TMDs consist of sandwiches of metal (e.g., Mo, W) and chalcogen atoms (S, Se, or Te) that in monolayer form assume atomic configurations known as the 1H, 1T, and 1T' phases (Figure 1a).<sup>7–11</sup> In the 1H phase, the top and bottom chalcogen layers are aligned, whereas in the 1T phase, the layers are shifted relative to each other, forming a hexagon of chalcogen atoms when viewed normal to the plane. The 1T' phase results from a distortion of the 1T structure, resulting in an isolated chain of chalcogen atoms.

One method to produce monolayer TMDs is mechanical or liquid exfoliation of the bulk. Mechanical exfoliation relies on adhesive tape to peel apart a layered crystal to monolayer thickness.<sup>12</sup> This yields high-quality monolayer material but very low surface coverage, making the method tedious and not

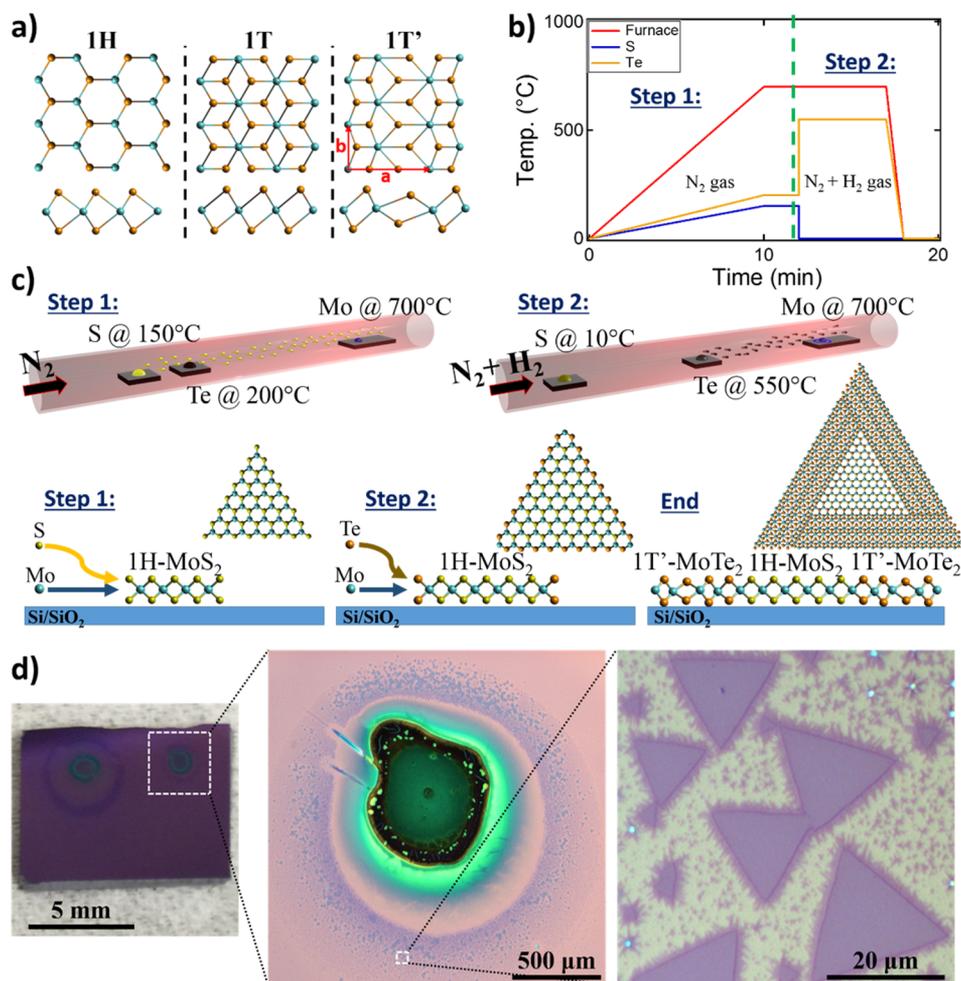
manufacturable. Liquid exfoliation relies on polymers and sonication to dissociate bulk crystals. It yields many monolayer regions but also unwanted surface contamination and/or structural damage.<sup>13</sup> Monolayer TMD flakes can also be grown by chemical vapor deposition (CVD) using solid or vapor precursors. The method is reproducible and yields large amounts of high-quality monolayer TMDs.<sup>14–17</sup>

Of the TMDs, 1H-MoS<sub>2</sub> and 1H-WSe<sub>2</sub> are the most widely synthesized and studied to date.<sup>18–22</sup> They are semiconductors with high on/off ratios, reasonable mobility values, large photoluminescence, and energy band gaps whose size is tuned by the thickness of the flake.<sup>21,23</sup> Monolayer 1H-MoS<sub>2</sub> (a semiconductor) can be transformed into metallic 1T-MoS<sub>2</sub> through chemical treatment with *n*-butyllithium, which was

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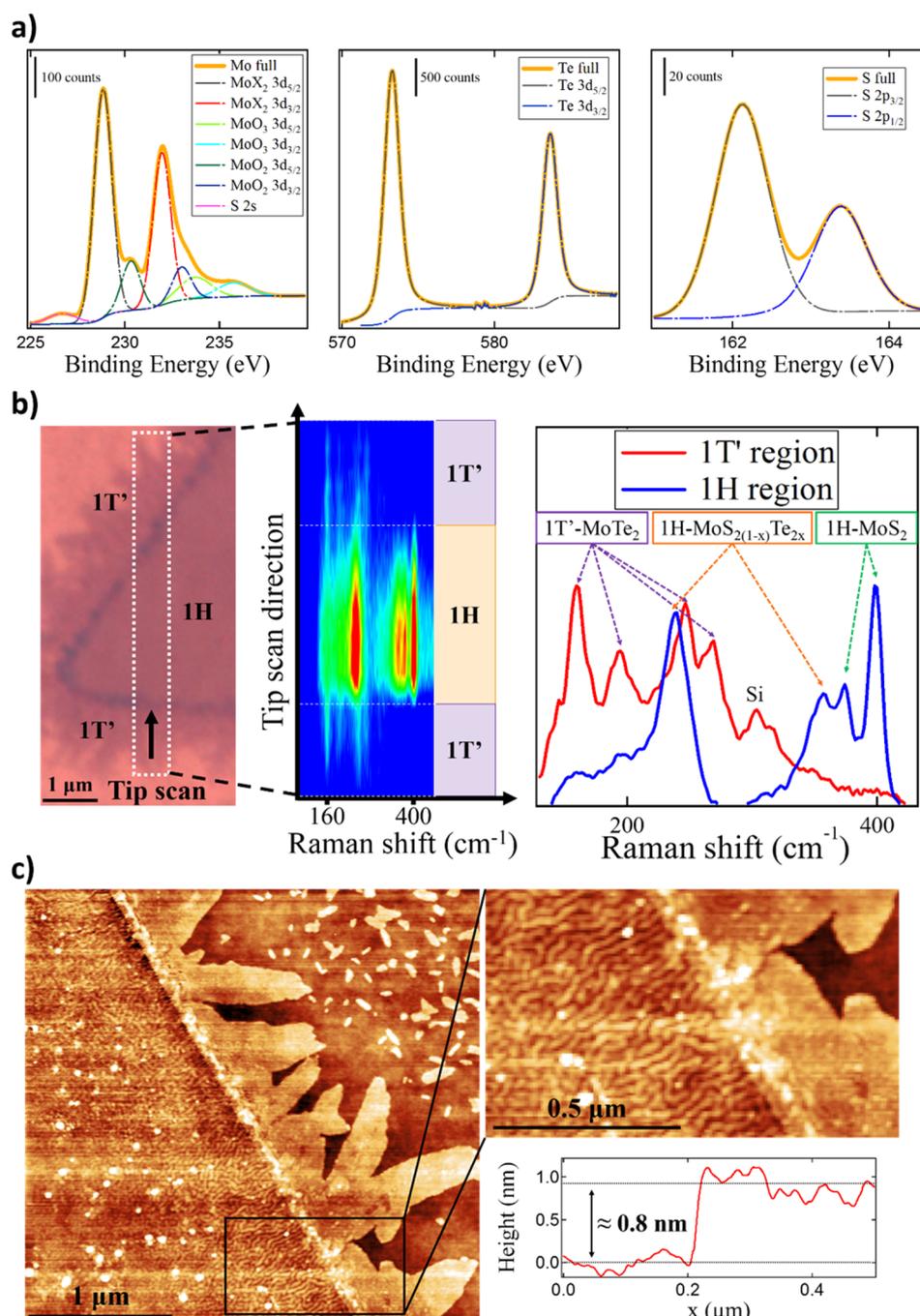


**Figure 1.** 1H/1T' growth. (a) Ball and stick diagrams for the 1H, 1T, and 1T' phases of monolayer metal dichalcogenides (metal atom in blue and chalcogen in orange). (b) Flow graph of the two-step growth process. (c) Schematic of the growth setup and process. (d) Optical micrographs of 1H/1T' flakes under increasing magnification.

used to create a 1H-MoS<sub>2</sub>/1T-MoS<sub>2</sub> heterostructure.<sup>11</sup> However, 1T-MoS<sub>2</sub> is unstable in air, and *n*-butyllithium is pyrophoric, complicating this approach. Groups have also reported phase transformations of exfoliated 1H-MoS<sub>2</sub> by rhenium intercalation and thermal annealing<sup>24</sup> and laser-enabled phase patterning of few-layer exfoliated MoTe<sub>2</sub> to yield 1H/1T' heterostructures.<sup>9</sup> To our knowledge, the synthesis of in-plane heterostructures of monolayer TMDs of different atomic configuration has not been reported to date.

1T'-MoTe<sub>2</sub> and 1T'-WTe<sub>2</sub> are semimetals that exhibit fascinating properties, including Weyl semimetallicity,<sup>25</sup> superconductivity,<sup>26</sup> large nonsaturating magnetoresistance,<sup>27</sup> quantum spin Hall effect,<sup>7</sup> and weak antilocalization.<sup>16,28</sup> These properties motivated efforts toward synthesis of monolayer 1T' TMDs. We reported growth of high-quality monolayer 1T'-MoTe<sub>2</sub> and 1T'-WTe<sub>2</sub>, along with physical property measurement and analysis.<sup>16,28</sup> These materials degrade rapidly in air but can be stabilized to enable detailed property measurements. Others have also reported synthesis of monolayer 1T' TMDs and observed optical dichroism and superconductivity.<sup>29,30</sup> In-plane lateral heterostructures that combine TMDs in the 1H and 1T' structure are of significant interest because they offer the prospect of multifunctional capability that cannot be obtained from heterostructures based solely on the 1H phase.

Here, we report the synthesis of monolayer 1H-MoS<sub>2</sub>/1T'-MoTe<sub>2</sub>, atomically "stitched" heterostructures. We also developed a method to passivate the heterostructure flakes using large-area CVD graphene. X-ray photoelectron spectroscopy (XPS) confirmed the chemical composition of the sample. Tip-enhanced Raman spectroscopy (TERS) demonstrated the distinction between the 1H and 1T' regions. The observed Raman modes were consistent with density functional perturbation theory (DFPT)<sup>31</sup> calculations and suggested Te for S substitution in the 1H-MoS<sub>2</sub> region. Atomic force microscopy (AFM) showed that heterostructure flakes were monolayers with buckling in the 1H region. DFPT simulations revealed a buckling mechanism due to Te substitution in the 1H-MoS<sub>2</sub> and a growth mechanism that correlated with observations. Aberration-corrected scanning transmission electron microscopy (ACSTEM) images confirmed the 1H and 1T' atomic configurations within a monolayer as well as the interfacial stitching structure. ACSTEM images also showed significant Te substitution in the 1H-MoS<sub>2</sub> region. Finally, we performed electrical measurements of a single 1H-1T' heterostructure flake and found that 1H-MoS<sub>2</sub> remained semiconducting in the presence of Te substitution and interfacial buckling. This study reveals a promising pathway to creation of in-plane TMD heterostructures and motivates



**Figure 2.** Characterization of 1H/1T' heterostructure flakes. (a) X-ray photoelectron spectroscopy data revealing the presence Mo, S, and Te compounds in the flake. (b) Tip-enhanced Raman spectroscopy results show clear differences between the 1H and 1T' regions. (c) AFM of a 1H/1T' flake indicates monolayer height, and the presence of wrinkles indicates buckling of the 1H region.

further work toward combining relatively unexplored 1T' TMDs with 1H TMDs.

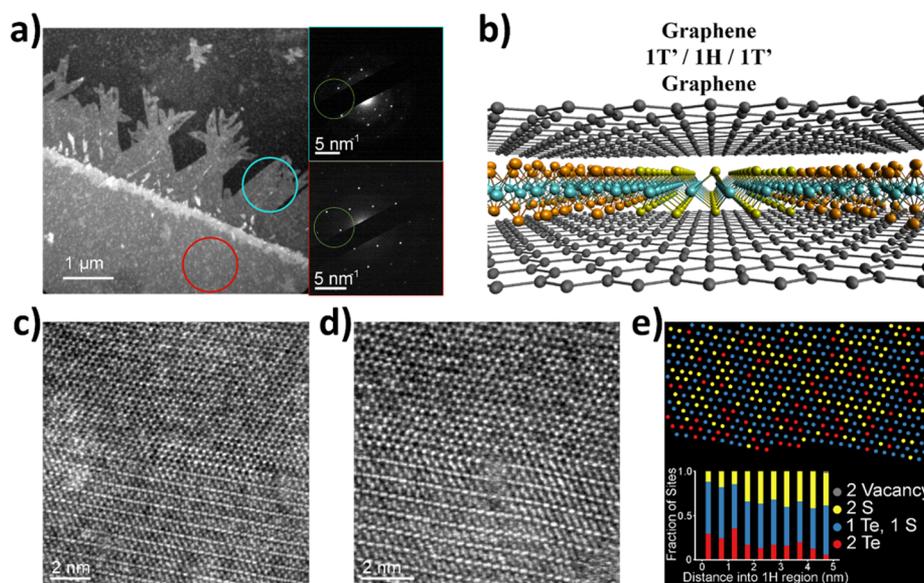
## RESULTS AND DISCUSSION

CVD synthesis of monolayer 1H/1T' was accomplished using ammonium heptamolybdate (AHM) and vapors of sulfur and tellurium as precursors (Figure 1b; growth details are provided in Methods). We first grew single-crystal 1H-MoS<sub>2</sub> flakes and then switched furnace conditions for growth of 1T'-MoTe<sub>2</sub> single-crystal flakes, which nucleated at 1H-MoS<sub>2</sub> edges to form a stitched heterophase interface (Figure 1c). Figure 1d shows a “coffee ring” of material around the AHM. At higher

magnification (Figure 1d), triangular 1H flakes are seen with 1T' needles growing from them, yielding a 1H/1T' heterostructure.

XPS was performed on 1H/1T' heterostructures to confirm their composition (Figure 2a). We identified the MoX<sub>2</sub> (3d<sub>5/2</sub>, 3d<sub>3/2</sub>) peaks as well as peaks for Te (3d<sub>5/2</sub>, 3d<sub>3/2</sub>) and S (2s, 2p<sub>3/2</sub>, 2p<sub>1/2</sub>), confirming the presence of Mo, S, and Te in the flakes. We also identified MoO<sub>3</sub> and MoO<sub>2</sub> (3d<sub>5/2</sub>, 3d<sub>3/2</sub>) peaks, which are ascribed to reaction of 1T'-MoTe<sub>2</sub> with ambient O<sub>2</sub>.<sup>16,28,32,33</sup>

Tip-enhanced Raman spectroscopy was used to study the vibrational spectrum of different regions of the heterostructure.



**Figure 3.** Characterization by TEM. (a) Dark-field TEM micrograph of the interface between a 1H region (bottom) and 1T' region (top) of a flake on a TEM carbon grid. The top-right image shows a SAED pattern from the circled 1T' region, and the bottom-right image shows a SAED pattern from the circled 1H region. A large objective aperture was used to select several diffracted beams (approximate aperture in green). (b) Schematic of graphene encapsulating a 1H/1T' heterostructure used for ACSTEM measurements. (c,d) Aberration-corrected high-angle annular dark-field (HAADF) images of the interface between 1H and 1T'. (e) Sulfur sites in the MoS<sub>2</sub> region in (d) labeled with number of tellurium substitutions estimated using the intensity of the site in the HAADF image. Inset is the occurrence of each substitution type as a function of distance from the boundary.

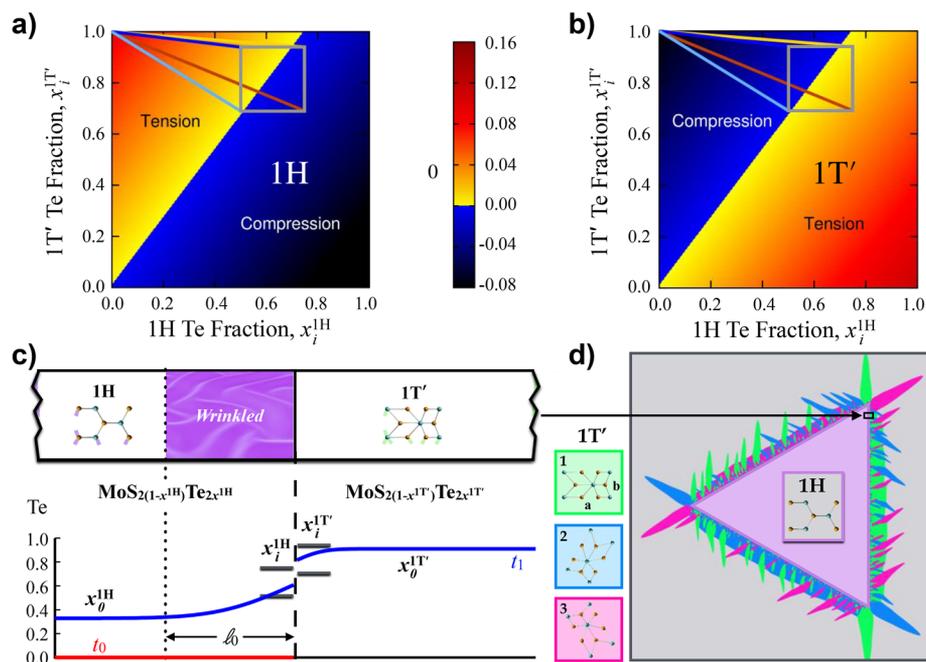
Because 1T'-MoTe<sub>2</sub> decays rapidly in air, the heterostructure growth substrate was covered with CVD-grown graphene before conducting measurements. For the data in Figure 2b, the scan line begins in a 1T' region, moves through 1H material, and then concludes in a 1T' section. The three regions were differentiated in the TERS map (Figure 2b), and their Raman-active modes were identified. In the 1T' regions (beginning and end of the scan line), we identified five modes at 160, 190, 248, 269, and 300 cm<sup>-1</sup>; the last is due to the Si substrate.<sup>34</sup> The other four peaks are the A<sub>g</sub> modes of monolayer 1T'-MoTe<sub>2</sub>, and the values are in excellent agreement with previous reports and theoretical predictions.<sup>16,32,35</sup> The 269 cm<sup>-1</sup> peak is confirmation of 1T'-MoTe<sub>2</sub> in monolayer form because this spectral line shifts for multilayer material toward a value of 258 cm<sup>-1</sup> for the bulk.<sup>36</sup>

In the center of the flake (1H region), we identified four modes: 240, 359, 372, and 400 cm<sup>-1</sup>. Stoichiometric 1H-MoS<sub>2</sub> exhibits two peaks, <sup>1</sup>E<sub>2g</sub> and A<sub>1g</sub>. We performed DFPT calculations of 1H-MoS<sub>2</sub> and found modes at 376 and 395 cm<sup>-1</sup>, consistent with previous reports.<sup>20,37</sup> These modes occur at frequencies similar to those observed at 372 and 400 cm<sup>-1</sup>, suggesting the presence of 1H-MoS<sub>2</sub> in the 1H region of the heterostructure. To explain the other two modes seen in TERS (240 and 359 cm<sup>-1</sup>), we performed DFPT simulations on 1H-MoS<sub>2(1-x)</sub>Te<sub>2x</sub> for  $x = 0.25$  and  $x = 0.5$ . The <sup>1</sup>E<sub>2g</sub> and A<sub>1g</sub> modes both red shift due to the more massive Te atoms. The E<sub>2g</sub> mode red shifts from 376 to 349 cm<sup>-1</sup> (340 cm<sup>-1</sup>) for  $x = 0.25$  ( $x = 0.5$ ), and the A<sub>1g</sub> mode shifts dramatically from 395 to 243 cm<sup>-1</sup> (217 cm<sup>-1</sup>). These two modes characteristic of 1H-MoS<sub>2(1-x)</sub>Te<sub>2x</sub> closely match the 359 and 240 cm<sup>-1</sup> modes observed for the 1H region in the heterostructure, with better agreement for  $x \sim 0.25$ ; moreover, the intensity of the A<sub>1g</sub> 400 cm<sup>-1</sup> mode is close to the 240 cm<sup>-1</sup>, and the E<sub>2g</sub> 372 cm<sup>-1</sup> matches the 359 cm<sup>-1</sup>, consistent with this assignment. We therefore propose a model for heterostructure growth, where

the triangular region was first grown as 1H-MoS<sub>2</sub>, but then during growth of the 1T'-MoTe<sub>2</sub> region, Te atoms insert into some S sites, converting nanoscale regions of the triangle into 1H-MoS<sub>2</sub>/1H-Mo MoS<sub>2(1-x)</sub>Te<sub>2x</sub> with  $0.25 \lesssim x \lesssim 0.5$ . These TERS results confirm the 1H/1T' nature of the heterostructure flakes and the identity of the 1T'-MoTe<sub>2</sub> material, and they also suggest the existence of Te substitution for S in the triangular 1H-MoS<sub>2</sub> region. This latter finding is consistent with DFT-based calculations<sup>38</sup> which indicate that 1H-MoS<sub>2(1-x)</sub>Te<sub>2x</sub> alloy thermodynamics favors mixing S and Te into a solid solution for  $T \gtrsim 230$  °C, whereas phase separation into Te-rich and S-rich domains is preferred for  $T \lesssim 230$  °C.<sup>39</sup>

Atomic force microscopy was used to investigate the height and structure of the heterostructure flakes (Figure 2c). We measured a height of approximately 0.8 nm at the edge of the flake, consistent with monolayer material, and noticed small multilayer regions along portions of the 1H/1T' interface. This indicates that 1T'-MoTe<sub>2</sub> growth occurred at the 1H-MoS<sub>2</sub> edge, preferentially in-plane but with some out-of-plane growth. We observed wrinkles at the 1H/1T' interface that extend ~500 nm into the 1H region. The observation of buckled 1H regions and flat 1T' regions is surprising considering the misfit between 1H-MoS<sub>2</sub> and 1T'-MoTe<sub>2</sub> crystals. In equilibrium,  $b_{1H-MoS_2} = 3.183$  Å and  $b_{1T'-MoTe_2} = 3.455$  Å,<sup>10</sup> such that the 1H side is under  $\epsilon_0^{1H} \approx 8.5\%$  (tensile) strain and the 1T' side is under  $\epsilon_0^{1T'} \approx -7.9\%$  (compressive) strain. If buckling occurs, it is expected in the 1T' region, not as observed in the 1H region. We return to this below.

Selected area electron diffraction (SAED) on regions of a heterostructure flake (Figure 3a) showed that the 1T'-MoTe<sub>2</sub> flakes grew fastest along the Te zigzag chain direction, resulting in a rectangular morphology with the long axis along the [010] crystal direction, consistent with our earlier report.<sup>16</sup> SAED also showed that the edges of the 1H region were oriented along its zigzag direction, and that the [010] directions in the 1T'-



**Figure 4.** Effects of composition, elastic misfit strain, and out-of-plane bending on heterostructure interfaces and growth morphology. (a,b) Maps of misfit strain as a function of Te fractions  $x_i^{1H}$  and  $x_i^{1T'}$  on the 1H and 1T' sides of the 1H/1T' interface, respectively. The gray rectangle encloses compositional bounds inferred from ACSTEM-derived lattice parameters near the interface. (c) Schematic of compositional domains and variation of Te composition near the 1H/1T' interface. Configurations are shown at the end of 1H-MoS<sub>2</sub> growth ( $t_0$ , red line) and at the end of 1T'-MoTe<sub>2</sub> growth ( $t_1$ , blue lines). Gray shaded areas are bounds shown in (a) and (b). (d) Simulated 1T' morphology at the misfit strain corresponding to  $x_i^{1H} = 0.75$  and  $x_i^{1T'} = 0.94$ . The color scheme employed for 1T' domains is shown on the left.

MoTe<sub>2</sub> flakes were oriented at 60 and 120° from parallel to the interface.

In order to gain understanding of the structure at the 1H–1T' interface, atomic-resolution ACSTEM was conducted on heterostructure flakes that had been encapsulated between graphene sheets (Figure 3b; fabrication details are in Methods) to prevent oxidation.<sup>28</sup> Aberration-corrected high-angle annular dark-field (HAADF) images showed that the orientation of rectangular 1T'-MoTe<sub>2</sub> regions away from the heterostructure interface did not directly reflect atomic stitching at the interface. Atomic-resolution images (Figure 3c,d) of the 1H–1T' interface show that the stitching mainly consisted of 1H-MoS<sub>2</sub> zigzag edges stitched to 1T'-MoTe<sub>2</sub> zigzag edges. This edge stitching is not represented in the lower-magnification image (Figure 3a) that shows 1T'-MoTe<sub>2</sub> flakes oriented 60 and 120° from the zigzag direction (see Figure S1 for details).

It seems surprising that despite the large misfit strain between 1H-MoS<sub>2</sub> and 1T'-MoTe<sub>2</sub> (in MoTe<sub>2</sub> the strain is  $\epsilon_0^{1T'} \approx -7.9\%$ ), neither interfacial misfit dislocations nor buckling was observed in the 1T' phase (1H buckling is seen). To relieve the entire misfit would require a large dislocation density with spacing  $s_0 = |b|/\epsilon_0^{1T'} \approx 4$  nm ( $b$  is the Burgers vector). We return to this below.

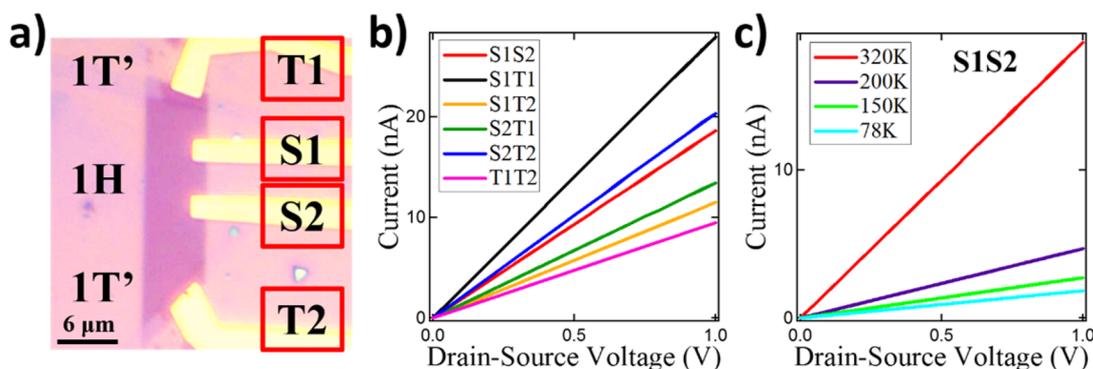
HAADF images also showed Te substitution near the interface. Since HAADF images are based upon mass contrast (intensity proportional to atomic number squared;  $Z_S = 16$ ,  $Z_{Mo} = 42$ ,  $Z_{Te} = 52$ ), identifying Te substitutions is straightforward. Figure 3e shows S<sub>2</sub> sites in a 1H region near the interface labeled with the number of Te substitutions, based on the HAADF intensity (see Figure S2). Heterostructure growth introduced single and double Te substitutions in the 1H region, especially near the interface, in agreement with TERS measurements. Te levels near the 1H/1T' interface ( $0.5 \lesssim$

$x_i^{1H} \lesssim 0.75$ ; see Figure 3) are enhanced relative to those in the 1H triangle interior ( $0.25 \lesssim x_0^{1H} \lesssim 0.5$  on average; see Figure 2).

This gradient in Te concentration between the 1H domain interior and the 1H side of the 1H/1T' interface generates the unexpected buckling on the 1H side. Te substitution creates biaxial compressive strain; the 1H lattice parameter increases with  $x_0^{1H}$  as  $b_{1H}(x_0^{1H}) \approx 3.183 + (3.55 - 3.183)x_0^{1H}$  (in Å). The compressive strain induced by Te substitution ( $\epsilon_{Te} \approx 0.115x_0^{1H}$ ) therefore increases from the interior of the 1H triangle toward the 1H/1T' interface by between  $\sim 0$  and  $\sim 5.5\%$  (corresponding to  $x_i^{1H} = x_0^{1H} = 0.5$  and  $x_0^{1H} = 0.25$ ,  $x_i^{1H} = 0.75$ , respectively). This variation occurs over  $\sim 1$   $\mu\text{m}$  (see Figure 2b), which is consistent with the experimentally observed width of the buckled strip in the 1H phase at  $\sim 0.5$   $\mu\text{m}$  (see Figure 2c).

The compressive strain associated with the Te concentration gradient can also be compared to the strain relieved by buckling. Using the wrinkle amplitude and wavelength from AFM images in Figure 2c ( $A \approx 0.4$  nm,  $\lambda \approx 25$  nm), we find that the strain relieved by buckling (in a one-dimensional sinusoidal approximation) is  $\epsilon_b = (L - L_0)/L_0 \approx (\pi A/\lambda)^2 \approx 0.25\%$ , where  $L$  is the arc length of the 1D profile over a distance  $L_0$ . This estimate of the strain released by the buckling (of the observed wavelength and amplitude) is consistent with the strain produced by the gradient in the Te concentration (i.e.,  $0 \leq \epsilon \leq -5.5\%$ ).

The large Te fraction near the 1H/1T' interface also accounts for the absence of buckling in the 1T' domains and the observed lack of interfacial misfit dislocations. Figure 4a,b shows the misfit strain on either side of the interface as a function of the concentrations on both sides of the interface, 1H-MoS<sub>2</sub>( $1-x_i^{1H}$ )Te<sub>2 $x_i^{1H}$</sub>  and 1T'-MoS<sub>2</sub>( $1-x_i^{1T'}$ )Te<sub>2 $x_i^{1T'}$</sub> . We estimate  $0.51 \lesssim x_i^{1H} \lesssim 0.75$  and  $0.69 \lesssim x_i^{1T'} \lesssim 0.94$  from the lattice



**Figure 5.** Electrical responses from the 1T'/1H/1T' structure. (a) Optical micrograph of a 1T'/1H/1T' device taken after completion of the measurements. Lack of optical contrast for 1T'-MoTe<sub>2</sub> regions away from the contact are due to oxidation. (b) Current-bias voltage ( $I$ - $V$ ) characteristics for different contact pairs, measured at room temperature. (c)  $I$ - $V$  characteristic at different temperatures for the 1H-MoS<sub>2</sub> region (S1-S2 contact pair).

parameters in the ACSTEM images. This composition variation creates misfit strains  $-2.6\% \lesssim \epsilon_0^{1H} \lesssim 2.1\%$  and  $-2.1\% \lesssim \epsilon_0^{1T'} \lesssim 2.6\%$  (gray rectangles in Figure 4a,b). This demonstrates that even though 1T'-MoTe<sub>2</sub> would be expected to be in compression when bonded to 1H-MoS<sub>2</sub>, the actual composition of these two phases makes the opposite possible (compression in the 1H phase, tension in 1T' consistent with the observation of 1H buckling). Because the compressive strain in the 1H phase is released by buckling, no interfacial misfit dislocations need to form to relax the strain.

The buckling in the 1H phase appears to be one-dimensional (1D) near the 1H/1T' interface and 2D further into the 1H. This indicates that the compressive stress near and tangential to the interface in 1H is larger than that perpendicular to it. This is consistent with the presence of tensile stresses in 1T' near the interface.

These findings demonstrate that thermodynamically driven intermixing of chalcogen species qualitatively alters the interfacial properties and strains in MoS<sub>2</sub>/MoTe<sub>2</sub> heterostructures from those that would be exhibited in the absence of compositional mixing. This highlights the fundamental roles of alloy thermodynamics, 2D material mechanics, and their interconnection in determining the properties of 2D material heterostructures.

The needle-like growth morphology of the 1T' domains differs from compact growth morphologies observed in lateral 1H/1H TMD heterostructures such as MoS<sub>2</sub>/WS<sub>2</sub><sup>41,42</sup> and MoSe<sub>2</sub>/WSe<sub>2</sub>.<sup>43</sup> In these systems, the 1H crystals have nearly identical lattice parameters, so the second phase grows with little deviation from the morphology of the parent phase. In contrast, isolated single-crystal 1T'-MoTe<sub>2</sub> flakes grow with needle-like shapes, with the short ( $b$ ) direction aligned with the long edge of the flake.<sup>16,32</sup> We performed DFT calculations which show that the  $b$  edge in 1T'-MoTe<sub>2</sub> has lower energy than the  $a$  edge ( $\lesssim 200$  and  $\sim 270$  meV/Å, respectively), which leads to elongated equilibrium flake shapes that are consistent with experimental observations (see the Supporting Information and Figures S3 and S4). Because 1T' nucleation occurs at the edge of the 1H flake, interface coherence dictates three possible orientations for the 1T' needles ( $b$  parallel to the flake edge or at 60 or 120°; see Figure 4d), precisely as observed in dark-field TEM images (Figure 3). An additional constraint in heterostructure growth, elastic coupling between phases, can independently control growth morphology. We performed continuum elastic phase field simulations of nucleation and

growth of 1T' domains bound to an elastically misfitting parent 1H crystal. The model describes how 1T' domains form and evolve to minimize elastic misfit energy during displacive 1H  $\rightarrow$  1T' structural transformations<sup>40</sup> (see the Supporting Information and Figures S5 and S6 for more details).

Figure 4d shows a representative morphology from a simulation with isotropic 1T' edge energies and misfit strain equal to that when  $x_i^{1H} = 0.75$  and  $x_i^{1T'} = 0.94$  (see Figure 4). The morphology is very similar to that of the synthesized heterostructure, with needles composed of two 1T' orientations at 60 or 120° from parallel to each triangular flake edge. A strip composed predominantly of the third orientation (0°) is observed along the inner portion of each edge, consistent with the observed [010] alignment of the 1H and 1T' lattices across the interface. A relatively uniform, compact triangular growth morphology is obtained in the absence of elastic misfit or when the misfit strain is shear-dominant rather than dilatation-dominant (see the Supporting Information). These results demonstrate that elastic misfit alone can induce needle-like 1T' growth morphologies, even in the absence of anisotropic edge energies and growth rates. At the estimated misfit strain and computed edge anisotropy of the present system, we expect that both effects contribute to the observed needle-like morphologies.

Field effect transistor devices were made from single heterostructures (Figure 5a) after reshaping the flake. Fabrication details are provided in the Methods section. The device was inserted in a vacuum probe station, and electrical data were collected at 10<sup>-7</sup> Torr. Useful data were collected from 5 of 15 separate devices on one growth substrate, with very similar results. Care was taken to ensure there were no gate leaks and that measured responses were due to the monolayer device structure.

Figure 5b shows electrical responses through all possible connections and shows that the 1H/1T' interface is electrically continuous. Higher current was observed in all samples for the S1T1 and S2T2 contacts compared to the S1S2 pair, even though the S1S2 contact pair has the least separation, which is ascribed to reduced contact resistance due to the semimetallic nature of the 1T' region. Figure 5c shows electrical transport through the 1H region at various temperatures. The current decreases with decreasing temperature, indicating that the 1H region remains semiconducting even with the buckling and Te substitution.

## CONCLUSIONS

We developed a CVD synthesis of 1H/1T' monolayer TMD heterostructures. The chemical composition and atomic structure of the heterostructure flakes were confirmed by XPS, tip-enhanced Raman spectroscopy, AFM, and ACSTEM, with interpretation guided by DFPT simulations. The data show enhanced Te substitution in the 1H-MoS<sub>2</sub> region that is enhanced near the interface, leading to buckling. The growth resulted in three distinct 1T'-MoTe<sub>2</sub> variants that were atomically stitched to the 1H phase with no misfit dislocations, as confirmed through ACSTEM images. The overall morphology was replicated in continuum phase field elastic growth simulations. Electrical measurements confirmed that the 1H region maintained its semiconducting properties. Future work will be directed toward reducing the Te substitution in order to maintain the intrinsic 1H-MoS<sub>2</sub> properties. This work provides a pathway to in-depth investigations of 1H/1T' TMD heterostructures and effects occurring at the one-dimensional interface of monolayer semiconductors and topological insulators.

## METHODS

**CVD Synthesis of 1H/1T' Heterostructures.** The Si/SiO<sub>2</sub> growth substrate was prepared by spin coating a growth promoter of 1% sodium cholate at 3000 rpm for 60 s. Sodium cholate is known to act as a growth promoter for 1H-MoS<sub>2</sub> and 1T'-MoTe<sub>2</sub>.<sup>14,16,44</sup> A microdroplet of a saturated solution of ammonium heptamolybdate was deposited onto the substrate to provide the molybdenum feedstock. The chip was then inserted into the center of a CVD furnace, with two source chips placed upstream, one chip with 25 mg of sulfur and the second with 25 mg of tellurium. The sulfur (tellurium) source was placed 18 cm (15 cm) from the growth substrate. The CVD furnace was then heated to 700 °C at a rate of 70 °C/min under a constant flow of 1000 sccm N<sub>2</sub>. The S chip reached a temperature of 150 °C and started to sublime, whereas the Te pellet was at 200 °C, well below its sublimation temperature of 550 °C (Figure 1c, step1). After 12 min of 1H-MoS<sub>2</sub> growth, we used a magnetic system to slide the Te substrate closer to the growth substrate, where it increased in temperature to 550 °C and began to sublime. We used the same system to slide the sulfur substrate away so that it rapidly cooled, and we adjusted the gas flow to 25 sccm H<sub>2</sub> and 400 sccm of N<sub>2</sub> (Figure 1c, step2). After a 5 min growth time, the furnace was rapidly cooled and the substrate retrieved.

**XPS.** The sample was transferred directly from the growth chamber to the XPS system loadlock and pumped down within 20 min of growth to minimize sample oxidation. Measurements were performed in the constant analyzer energy mode using a customized XPS spectrometer with a monochromatized Al K $\alpha$  source.<sup>45</sup> Data were analyzed using CasaXPS software (v2.3.16, Casa Software Ltd., Wilmslow, Cheshire, U.K.). The XPS spectrometer was calibrated in accordance with ISO 15472:2001 to an accuracy of better than  $\pm 0.05$  eV for the 100 eV pass energy used for the high-resolution spectra and the 200 eV pass energy used for the survey spectra. High-resolution spectra were fit with peak shapes composed of a convolution of Gaussian and Lorentzian functions superimposed atop a Shirley–Sherwood background.<sup>46</sup> Synthetic peaks were constrained to have appropriate intensity ratios for spin–orbit split states and the same fwhm, with the exception of the Mo 3d components for MoO<sub>3</sub>. High-resolution spectra revealed the presence of charging due to the thickness of the SiO<sub>x</sub> layer on the Si substrate. This effect was corrected for all high-resolution spectra by shifting the aliphatic carbon peak, which was the most intense component of the C 1s spectra, to 285.0 eV.<sup>47</sup> Peak positions are reported as an average of the two analyzed regions along with the spread of the data. Mo 3d high-resolution spectra were fit with seven components: S 2s at 226.65  $\pm$  0.02 eV, Mo 3d<sup>5/2</sup> from Te<sub>x</sub>Mo<sub>3</sub>S<sub>2</sub> at 228.85  $\pm$  0.02 eV, MoO<sub>2</sub> 3d<sup>5/2</sup> at 230.31  $\pm$  0.01 eV, Te<sub>x</sub>Mo<sub>3</sub>S<sub>2</sub> 3d<sup>3/2</sup> at 231.98  $\pm$  0.03 eV, MoO<sub>2</sub> 3d<sup>3/2</sup> at

233.04  $\pm$  0.04 eV, MoO<sub>3</sub> 3d<sup>5/2</sup> at 233.74  $\pm$  0.04 eV, and MoO<sub>3</sub> 3d<sup>3/2</sup> at 235.92  $\pm$  0.16 eV.<sup>48,49</sup> Te 3d spectra were fit with two components: Te 3d<sup>5/2</sup> from Te<sub>x</sub>Mo<sub>3</sub>S<sub>2</sub> at 573.26  $\pm$  0.01 eV and Te<sub>x</sub>Mo<sub>3</sub>S<sub>2</sub> 3d<sup>3/2</sup> at 583.65  $\pm$  0.02 eV. S 2p spectra were fit with two components: 2p<sup>3/2</sup> from Te<sub>x</sub>Mo<sub>3</sub>S<sub>2</sub> at 162.15  $\pm$  0.03 eV and Te<sub>x</sub>Mo<sub>3</sub>S<sub>2</sub> 2p<sup>1/2</sup> at 163.36  $\pm$  0.02 eV.

**Selected Area Electron Diffraction.** The SAED patterns were taken in a JEOL 2100 operated at 200 kV. The heterostructure flakes were transferred onto a TEM carbon grid using a previously described HF transfer process.<sup>16</sup> A selected area aperture with a 1  $\mu$ m effective diameter at the specimen was used.

**Graphene Growth.** Graphene synthesis was carried out in a low-pressure CVD furnace (OTF-1200X-4-C4-SL-UL, MTI Corp.). Cu foils (Alfa Aesar Item #46365) were cleaned with 5.4% HNO<sub>3</sub> for 40 s and two deionized (DI) water baths for 2 min and then blown dry with N<sub>2</sub> gas. The reaction chamber was pumped to a base pressure of  $\sim$ 50 mTorr. The Cu growth substrate was annealed at 1020 °C for 30 min under a gas flow of 500 sccm Ar and 80 sccm H<sub>2</sub>. Monolayer graphene was then grown using methane as a carbon source at a flow rate of 5 sccm for 5 min and then 10 sccm for 15 min. The reactor was subsequently cooled to room temperature rapidly under a flow of 80 sccm H<sub>2</sub> and 10 sccm CH<sub>4</sub>.

**Graphene Passivation.** Monolayer graphene was grown by CVD following the recipe discussed in the previous paragraph. Two pieces of graphene on Cu foil were spin coated at 3000 rpm for 60 s with C4 PMMA and then released from the Cu foil by the bubble transfer method and left floating in DI water. The first sheet of graphene was transferred onto the as-grown heterostructure flakes, and the second sheet of graphene was transferred onto a holey carbon TEM grid. The PMMA layer on top of the graphene/TEM grid was dissolved with acetone, followed by isopropyl alcohol (IPA). The PMMA/graphene/1H–1T' heterostructure stack on the SiO<sub>2</sub>/Si growth substrate was then released using a diluted HF solution of 1:25 and quickly washed in two DI water baths before being transferred onto the first graphene sheet on the TEM grid. Acetone was then used to dissolve the PMMA followed by IPA. We were then left with a graphene/1H–1T' heterostructure/graphene on a TEM grid (Figure 3b). The sample was stable in this configuration and could be transported to the ACSTEM for high-resolution imaging.

**Aberration-Corrected HAADF.** Aberration-corrected HAADF imaging was performed with a JEOL ARM 200CF with a corrector on the STEM probe and operated at 80 kV. The flakes were encapsulated between two graphene layers and transferred onto a holey carbon grid to slow oxidation outside of the TEM<sup>16</sup> and electron-beam-induced damage in the TEM, as the graphene is effectively invisible on MoS<sub>2</sub>/MoTe<sub>2</sub> in the mass contrast HAADF images (Figure 3b).<sup>50</sup>

**Device Fabrication.** An as-grown sample of triangular 1H/1T' flakes was spin coated at 3000 rpm for 60 s with C4 PMMA. Electron beam lithography (EBL) and plasma etching were used to define a rectangular region, where the ends of the rectangle were 1T' material and the center region was 1H. A new layer of C4 resist was then applied to the substrate and marker regions were patterned by EBL. Optical microscopy was used to locate the rectangular flake with respect to the markers. A final round of EBL was performed to pattern contacts that were aligned to the 1H and 1T' regions, and the contacts were metallized with 3 nm of Cr and 40 nm of Au deposited by thermal evaporation. This was followed by lift-off in an acetone bath and a rinse in IPA. The sample was then dried by a N<sub>2</sub> gun and immediately stored under vacuum for transfer to the measurement system.

## ASSOCIATED CONTENT

### Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsnano.7b03828.

SAED and ACSTEM determination of lattice orientation; histogram of intensities of S and Mo sites in Figure 3e; characterization of 1H/1T' heterostructures; first-

principles calculations of 1T'-MoTe<sub>2</sub> edge energies; phase field simulations of heterostructure growth (PDF)

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### Author Contributions

A.T.C.J. directed the research. C.H.N. proposed and designed the experiment and carried out 1H-1T' growth and AFM measurements. J.B.M. performed XPS measurement under the supervision of R.W.C. Q.Z., C.H.N., and C.E.K. performed TERS measurements and analysis. L.Z.T. performed Raman simulations under the supervision of A.M.R. W.M.P. performed TEM measurements under the supervision of M.D. Graphene growth was carried out by Z.G. Device fabrication and measurements were performed by C.H.N. and R.S.G. The phase field simulations and first-principles calculations were performed by J.B. and S.Z. under the supervision of D.J.S. C.H.N. and A.T.C.J. wrote the manuscript with input and approval from all authors.

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### Notes

The authors declare no competing financial interest.

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